## Stat210B: Theoretical Statistics

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## Lecture 19: Asymptotic Relative Efficiency

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## 1 Asymptotic Relative Efficiency

We will be working in the context of hypothesis testing where we have

null hypothesis  $H_0$ :  $\theta \in \Theta_0$  alternative  $H_1$ :  $\theta \in \Theta_1$ 

and  $\Theta_0 \cup \Theta_1$  is typically exhaustive and non-overlapping.

We will denote the *critical region* by  $K_n$  and the *power function* is  $\pi_n(\theta) = P_{\theta}(T_n \in K_n)$  where  $T_n$  is our test statistic. The *size of the test* is  $\sup\{\pi_n(\theta): \theta \in \Theta_0\}$ . A test is of level  $\alpha$  if its size is  $\leq \alpha$ .

A test is asymptotically of size  $\alpha$  if

$$\limsup_{n \to \infty} \sup_{\theta \in \Theta_0} \pi_n(\theta) \le \alpha$$

We will look at the limiting power function of shrinking alternatives

$$\pi(h) = \lim_{n} \pi_n(h/\sqrt{n})$$

**Theorem 1.** Theorem 14.7 in (?, p. 195). Assume without loss of generality that  $\theta_0 = 0$  and therefore that our shrinking set of alternatives is  $\theta_n = h/\sqrt{n}$ . Also assume that

$$\sqrt{n} \frac{T_n - \mu(\theta_n)}{\sigma(\theta_n)} \stackrel{\theta_n}{\leadsto} \mathcal{N}(0, 1)$$

for some  $\mu$  and  $\sigma$  where  $\mu$  is differentiable at 0 and  $\sigma$  is continuous at 0. Then the tests that reject for large values of  $T_n$  and are asymptotically of level  $\alpha$  have power functions that satisfy

$$\pi_n(h/\sqrt{n}) \to 1 - \Phi\left(z_\alpha - h\mu'(0)/\sigma(0)\right)$$

where  $\mu'(0)/\sigma(0)$  is called the slope (or efficiency) of the test.

Proof.

$$\pi_n(h/\sqrt{n}) \triangleq P_{\theta_n} \left( \sqrt{n} (T_n - \mu(0)) > z_{\alpha} \sigma(0) \right)$$

$$= P_{\theta_n} \left( \sqrt{n} (T_n - \mu(h/\sqrt{n})) > z_{\alpha} \sigma(0) - \sqrt{n} (\mu(h/\sqrt{n}) - \mu(0)) \right)$$

$$\to 1 - \Phi(z_{\alpha} - h\mu'(0)/\sigma(0))$$

where we have arrived at the last line since

$$\frac{\mu(h/\sqrt{n}) - \mu(0)}{h/\sqrt{n}} \to \mu'(0)$$

and by continuity of  $\sigma$ , we have  $\sigma(\theta_n) \to \sigma(0)$ .

**Definition 2** (Asymptotic relative efficiency). The Asymptotic Relative Efficiency (ARE) is the ratio of the squares of slopes between two statistics.

**Example 3** (Sign test). This example is from Van der Vaart, but presents a different derivation than is found in the book.

- Let  $X_1, X_2, \ldots, X_n$  be i.i.d. from a symmetric density  $f(x \theta)$ .
- Let our test statistic be  $S_n = \frac{1}{n} \sum_i 1_{X_i > 0}$
- At  $\theta = 0$ , this is the sum of Bernoulli variables with probability 1/2, so  $\sigma^2(0) = 1/4$ .

Remember that location families are qmd (as mentioned in lecture on 3/8) and that for qmd families,  $P_{\theta+h/\sqrt{n}} \triangleleft P_{\theta}$  (see example 14 from the 3/13 lecture notes). Also, for location families,  $\dot{\ell}_0 = -f'(x)/f(x)$ . By contiguity, to get the distribution of the statistics under  $P_{\theta_n}$ , compute  $\tau_{12}$ . To compute  $\tau_{12}$ , we note that this statistic is an (asymptotically) linear statistic, so by the results from example 4 from the 3/15 lecture notes),  $\tau_{12}$  is equal to

$$\tau_{12} = \operatorname{Cov}_{0}(1_{X>0}, h^{\top} \dot{\ell}_{0}(X))$$

$$= -h \int 1_{x>0} \frac{f'(x)}{f(x)} f(x) dx$$

$$= -h \int_{0}^{\infty} f'(x) dx$$

$$= hf(0)$$

Therefore the slope of the sign test is 2f(0). It is good to have larger slopes, so this test will be better if there is a lot of mass around the origin.

**Example 4** (t-test). In example 5 from the 3/15 lecture notes, we showed that for the t-statistic,  $\tau_{12} = h/\sigma$  and the variance under the null is 1, so the slope of the t-statistic is

$$\frac{1}{(\int x^2 f(x) dx)^{1/2}}$$

Therefore, we compute that the ARE of the sign test vs. the t-test is  $4f^2(0) \int x^2 f(x) dx$ . If this is > 1, then the sign test is better, if it is < 1, the t-test is better. We compute the AREs as

f distribution	ARE(sign, t)	t-test better?
logistic	$\pi^2/12$	yes
normal	$2/\pi$	yes
Laplace	2	no
uniform	1/3	yes

Note: Why do we square the slopes in the ARE ratio? This leads to ARE(A,B) being the number of points for A to be competitive with B. We will return to this later.

It turns out that above, we can show that 1/3 is a lower bound on the ARE using calculus of variations. Therefore, the uniform is the worst case for the sign test compared to the t-test.

**Example 5** (2 sample tests for shift of location of  $f(x - \theta)$  under the null  $\theta = 0$  vs.  $\theta > 0$ ). The Mann-Whitney test for m and n samples respectively of  $x_i$  and  $y_j$  rejects if

$$\frac{1}{mn} \sum_{i} \sum_{j} 1_{x_i \le y_j}$$

is large. We will compare this to the two sample t-test. The Mann-Whitney statistic is a U-statistic, so we have a formula for computing its variance (or use contiguity) to get that the slope is  $\int f dF/\sigma(0)$ . Looking up the slope of the two-sample t-test, the ARE between the Mann-Whitney test and the t-test is  $12\text{Var}X(\int f^2(y)dy)^2$ . This gives the chart

f distribution	ARE(M-W, t)	t-test better?
logistic	$\pi^{2}/9$	no
normal	$3/\pi$	yes
Laplace	3/2	no
uniform	1	equivalent
$t_{3-\mathrm{dof}}$	1.24	no
$t_{3-\mathrm{dof}}$	1.9	no
$c(1-x^2)\vee 0$	108/125	yes

Again, it can be shown using calculus of variations that 108/125 is the worst that the ARE can be, so the Mann-Whitney test can never be that much worse than the t-test, but it can be much better. The above two tables support our intuition that the sign test can lose a decent amount of information since it throws out a lot of information, but rank tests don't throw out as much, so they are competitive.

## 2 Interpreting the ARE

As mentioned above, the ARE is the number of points needed to achieve the same power between two tests. Let  $\theta_{\nu}$  be an alternative sequence where  $\nu \to \infty$  where  $\nu$  is the rate of gathering data. Define  $n_{\nu}$  to be the minimal number of observations such that  $\pi_{n_{\nu}}(0) \le \alpha$  (since  $\theta = 0$  is the null and the power at the null = the type-1 error rate, which we want to be  $\le \alpha$ ) and  $\pi_{n_{\nu}}(\theta_{\nu}) \ge \gamma$  for some  $\gamma \in (\alpha, 1)$ . Do this for two tests, yielding  $n_{\nu,1}$  and  $n_{\nu,2}$  for tests 1 and 2, respectively.

**Definition 6** (Pitman efficiency). The *Pitman efficiency* is defined as

$$\lim_{\nu \to \infty} \frac{n_{\nu,2}}{n_{\nu,1}}$$

**Theorem 7.** Theorem 14.19 in (?, p. 201). Assume we are dealing with models  $\{P_{n,\theta}: \theta \geq 0\}$ . Also assume that  $\theta > 0$  and the total variation distance  $||P_{n,\theta} - P_{n,0}|| \to 0$  as  $\theta \downarrow 0$ . Let  $T_{n,1}$  and  $T_{n,2}$  be two statistics that satisfy

$$\sqrt{n} \frac{T_{n,i} - \mu_i(\theta_n)}{\sigma_i(\theta_n)} \stackrel{\theta_n}{\leadsto} \mathcal{N}(0,1)$$

for  $\theta_n \downarrow 0$ ,  $\mu'_i(0) > 0$ ,  $\sigma_i(0) > 0$ , and  $\sigma_i$  continuous at 0. Then we have that the Pitman efficiency is equal to the ARE, i.e.

$$\lim_{\nu \to \infty} \frac{n_{\nu,2}}{n_{\nu,1}} = \left(\frac{\mu_1'(0)/\sigma_1(0)}{\mu_2'(0)/\sigma_2(0)}\right)^2$$

This is true for any  $\theta_n \downarrow 0$  independent of  $\alpha$  and  $\gamma$ .

*Proof.* First, we need to show that  $n_{\nu_i} \to \infty$  for both *i*. This proof is given in the book (it arises from the assumption that the variation distance goes to zero). Since  $n_{\nu,i} \to \infty$ , we can use the assumption of asymptotic normality of  $T_{n,i}$  to define tests of level  $\alpha$ : we reject when

$$\sqrt{n_{\nu,i}}(T_{n_{\nu},i} - \mu_i(0)) > \sigma_i(0)z_{\alpha} + o(1)$$

Then the power of this test is

$$\pi_{n_{\nu},i}(\theta_{\nu}) = 1 - \Phi\left(z_{\alpha} + o(1) - \sqrt{n_{\nu,i}}\theta_{\nu}\mu_{i}'(0)/\sigma_{i}(0)(1 + o(1))\right) + o(1)$$

where we have used the same derivative trick to get  $\mu'_i(0)$  as before. This tends to level  $\gamma < 1$  iff the arguments of  $\Phi$  tends to  $z_{\gamma}$ . Therefore

$$\lim_{\nu \to \infty} \frac{n_{\nu,2}}{n_{\nu,1}} = \lim_{\nu \to \infty} \frac{n_{\nu,2} \theta_{\nu}^{2}}{n_{\nu,1} \theta_{\nu}^{2}}$$

$$= \frac{(z_{\alpha} - z_{\gamma})^{2}}{(\mu'_{2}(0)/\sigma_{2}(0))^{2}} \frac{(z_{\alpha} - z_{\gamma})^{2}}{(\mu'_{1}(0)/\sigma_{1}(0))^{2}}$$

$$= \left(\frac{\mu'_{1}(0)/\sigma_{1}(0)}{\mu'_{2}(0)/\sigma_{2}(0)}\right)^{2}$$
= the ratio of the square of the slopes

This has all been for 1-D cases. It gets harder in higher dimensional spaces. See the text for a flavor of higher dimensions.